Power MOSFET

-30 V, -1.95 A, Single, P-Channel, SOT-23

Features

- Leading Planar Technology for Low Gate Charge / Fast Switching
- Low R_{DS(ON)} for Low Conduction Losses
- SOT-23 Surface Mount for Small Footprint (3 X 3 mm)
- Pb-Free Packages are Available

Applications

- DC to DC Conversion
- Load/Power Switch for Portables and Computing
- Motherboard, Notebooks, Camcorders, Digital Camera's, etc.
- Battery Charging Circuits

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	-30	V
Gate-to-Source Voltage			V_{GS}	±20	V
Drain Current (Note 1)	t < 10 s T _A = 25°C		I _D	-1.95	Α
		T _A = 70°C		-1.56	
Power Dissipation (Note 1)	t < 10 s		P _D	1.25	W
Continuous Drain Current	Steady	T _A = 25°C	I _D	-1.13	Α
(Note 1)	State	T _A = 70°C		-0.90	
Power Dissipation (Note 1)	Stead	dy State	P _D	0.4	W
Pulsed Drain Current	t _p =	10 μs	I _{DM}	-6.8	Α
Operating Junction and Storage Temperature			T _J , T _{STG}	-55 to 150	°C
Source Current (Body Diode)			I _S	-1.25	Α
Lead Temperature for Soldering Purposes (1/8 in from case for 10 s)			T _L	260	°C

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	300	°C/W
Junction-to-Ambient - t = 10 s (Note 1)	$R_{\theta JA}$	100	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface-mounted on FR4 board using 1 in sq. pad size (Cu area = 1.127 in sq. [1 oz] including traces).

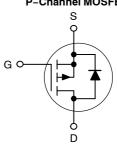


ON Semiconductor®

http://onsemi.com

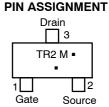
V	(BR)DSS	R _{DS(on)} TYP	I _D Max (Note 1)
	-30 V	155 mΩ @ –10 V	1.05.4
'		240 mΩ @ -4.5 V	–1.95 A

P-Channel MOSFET





SOT-23 CASE 318 STYLE 21



MARKING DIAGRAM/

TR2 = Device Code

M = Date Code*

Pb-Free Package

(Note: Microdot may be in either location)

*Date Code orientation and/or overbar may vary depending upon manufacturing location.

ORDERING INFORMATION

Device	Package	Shipping†
NTR4502PT1	SOT-23	3000 / Tape & Reel
NTR4502PT1G	SOT-23 (Pb-Free)	3000 / Tape & Reel
NTR4502PT3	SOT-23	10000 / Tape & Reel
NTR4502PT3G	SOT-23 (Pb-Free)	10000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

Electrical Characteristics ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$		-30			V
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 \text{ V}, V_{DS} = -30 \text{ V}$	Γ _J = 25°C			-1	μΑ
		 	Γ _J = 55°C			-10	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = ±20 V				±100	nA
ON CHARACTERISTICS (Note 3)						-	•
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = -250 \mu A$		-1.0		-3.0	V
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = -10 V, I _D = -1.95 A			155	200	mΩ
		V _{GS} = -4.5 V, I _D = -1.5 A			240	350	
Forward Transconductance	9FS	V _{DS} = -10 V, I _D =-1.25 A			3		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = -15 V			200		pF
Output Capacitance	C _{OSS}				80		
Reverse Transfer Capacitance	C _{RSS}				50		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = -10 V, V _{DS} = -15 V; I _D = -1.95 A			6	10	nC
Threshold Gate Charge	Q _{G(TH)}				0.3		
Gate-to-Source Charge	Q_{GS}				1		
Gate-to-Drain Charge	Q_{GD}				1.7		1
SWITCHING CHARACTERISTICS (Note	4)						
Turn-On Delay Time	t _{d(ON)}	V_{GS} =-10 V, V_{DD} = -15 V, I_{D} = -1.95 A, R_{G} = 6 Ω			5.2	10	ns
Rise Time	t _r				12	20	1
Turn-Off Delay Time	t _{d(OFF)}				19	35	1
Fall Time	t _f				17.5	30	1
DRAIN-SOURCE DIODE CHARACTERIS	STICS (Note 3)		•			-	-
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 \text{ V}, I_S = -1.25 \text{ A}$			-0.8	-1.2	V
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V}, \text{ dI}_{SD}/\text{d}_{t} = 100 \text{ A/}\mu\text{s}, \text{ I}_{S} = -1.25 \text{ A}$			23		ns
		•					

Surface-mounted on FR4 board using 1 in sq. pad size (Cu area = 1.127 in sq. [1 oz] including traces).
 Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

ID, DRAIN CURRENT (A)

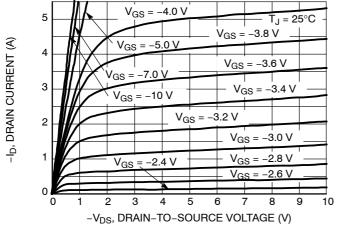


Figure 1. On-Region Characteristics

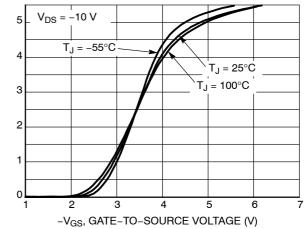


Figure 2. Transfer Characteristics

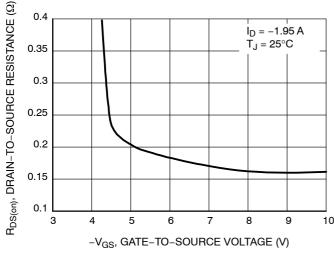


Figure 3. On-Resistance versus Gate-to-Source Voltage

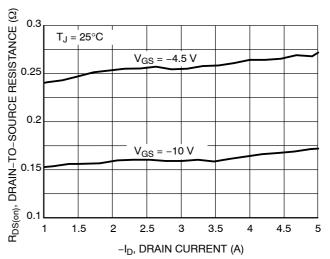


Figure 4. On-Resistance versus Drain Current and Gate Voltage

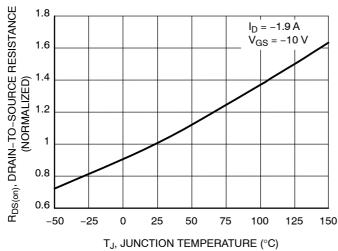


Figure 5. On–Resistance Variation with Temperature

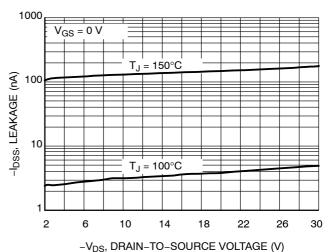


Figure 6. Drain-to-Source Leakage Current versus Voltage

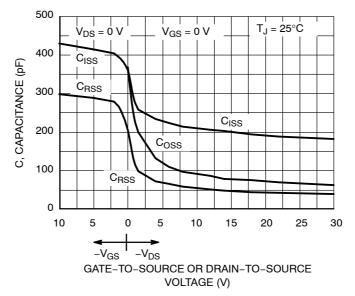


Figure 7. Capacitance Variation

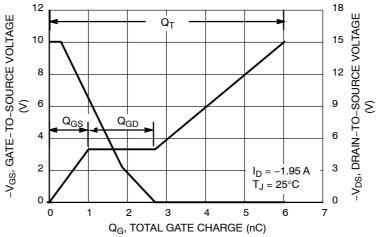


Figure 8. Gate-to-Source and Drain-to-Source Voltage versus Total Charge

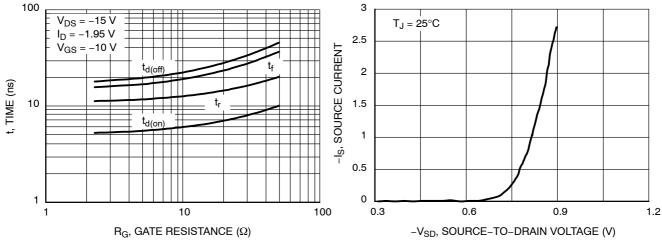
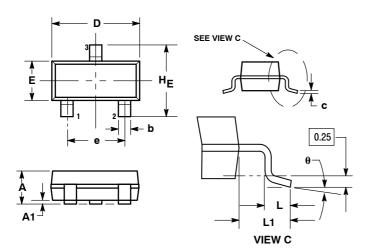


Figure 9. Resistive Switching Time Variation versus Gate Resistance

Figure 10. Diode Forward Voltage versus Current

PACKAGE DIMENSIONS

SOT-23 (TO-236) CASE 318-08 **ISSUE AN**



NOTES:

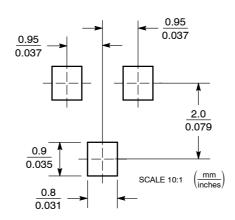
- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- CONTROLLING DIMENSION: INCH.
 MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.
- 318-01 THRU -07 AND -09 OBSOLETE, NEW STANDARD 318-08.

	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.89	1.00	1.11	0.035	0.040	0.044
A1	0.01	0.06	0.10	0.001	0.002	0.004
b	0.37	0.44	0.50	0.015	0.018	0.020
С	0.09	0.13	0.18	0.003	0.005	0.007
D	2.80	2.90	3.04	0.110	0.114	0.120
E	1.20	1.30	1.40	0.047	0.051	0.055
е	1.78	1.90	2.04	0.070	0.075	0.081
L	0.10	0.20	0.30	0.004	0.008	0.012
L1	0.35	0.54	0.69	0.014	0.021	0.029
HE	2.10	2.40	2.64	0.083	0.094	0.104

STYLE 21:

- GATE 2. SOURCE
- DRAIN

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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